

## N-channel 620 V, 1.28 $\Omega$ typ., 5.0 A Power MOSFET in I<sup>2</sup>PAKFP and TO-220 packages

Datasheet – preliminary data

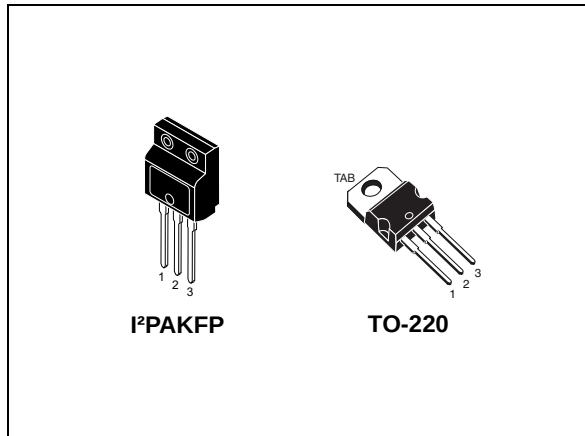
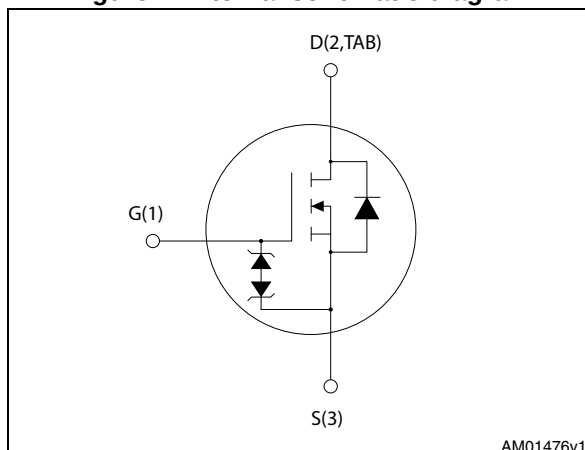


Figure 1. Internal schematic diagram



### Features

| Order codes | V <sub>DS</sub> | R <sub>DS(on)</sub><br>max | I <sub>D</sub> | P <sub>TOT</sub> |
|-------------|-----------------|----------------------------|----------------|------------------|
| STFILED625  | 620 V           | 1.6 $\Omega$               | 5.0 A          | 25 W             |
| STPLED625   |                 |                            |                | 70 W             |

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Improved diode reverse recovery characteristics
- Zener-protected

### Applications

- LED lighting applications

### Description

These Power MOSFETs boast extremely low on-resistance and very good dv/dt capability, rendering them suitable for buck-boost and flyback topologies.

Table 1. Device summary

| Order codes | Marking | Package                       | Packaging |
|-------------|---------|-------------------------------|-----------|
| STFILED625  | LED625  | I <sup>2</sup> PAKFP (TO-281) | Tube      |
| STPLED625   |         | TO-220                        |           |

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# 1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol                             | Parameter                                                                                                                  | Value                |        | Unit |
|------------------------------------|----------------------------------------------------------------------------------------------------------------------------|----------------------|--------|------|
|                                    |                                                                                                                            | I <sup>2</sup> PAKFP | TO-220 |      |
| V <sub>DS</sub>                    | Drain- source voltage                                                                                                      | 620                  |        | V    |
| V <sub>GS</sub>                    | Gate- source voltage                                                                                                       | ± 30                 |        | V    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> = 25 °C                                                                       | 5.0 <sup>(1)</sup>   | 5.0    | A    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> = 100 °C                                                                      | 3.5 <sup>(1)</sup>   | 3.5    | A    |
| I <sub>DM</sub> <sup>(2)</sup>     | Drain current (pulsed)                                                                                                     | 20.0 <sup>(1)</sup>  | 20.0   | A    |
| P <sub>TOT</sub>                   | Total dissipation at T <sub>C</sub> = 25 °C                                                                                | 70                   | 25     | W    |
| I <sub>AR</sub>                    | Avalanche current, repetitive or not-repetitive (pulse width limited by T <sub>J</sub> max)                                | 4.2                  |        | A    |
| E <sub>AS</sub>                    | Single pulse avalanche energy (starting T <sub>J</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V) | 120                  |        | mJ   |
| dv/dt <sup>(3)</sup>               | Peak diode recovery voltage slope                                                                                          | 12                   |        | V/ns |
| di/dt <sup>(3)</sup>               | Diode reverse recovery current slope                                                                                       | 400                  |        | A/μs |
| V <sub>ISO</sub>                   | Insulation withstand voltage (AC)                                                                                          | 2500                 |        | V    |
| T <sub>J</sub><br>T <sub>stg</sub> | Operating junction temperature<br>Storage temperature                                                                      | - 55 to 150          |        | °C   |

1. Limited only by maximum temperature allowed
2. Pulse width limited by safe operating area
3. I<sub>SD</sub> ≤ I<sub>D</sub>, peak V<sub>DS</sub> ≤ V<sub>(BR)DSS</sub>, V<sub>DD</sub> = 80% V<sub>(BR)DSS</sub>

Table 3. Thermal data

| Symbol                | Parameter                            | Value                |        | Unit |
|-----------------------|--------------------------------------|----------------------|--------|------|
|                       |                                      | I <sup>2</sup> PAKFP | TO-220 |      |
| R <sub>thj-case</sub> | Thermal resistance junction-case max | 5                    | 1.79   | °C/W |
| R <sub>thj-amb</sub>  | Thermal resistance junction-amb max  | 62.50                |        | °C/W |

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

**Table 4. On /off states**

| Symbol        | Parameter                                        | Test conditions                                                               | Min. | Typ. | Max.     | Unit                           |
|---------------|--------------------------------------------------|-------------------------------------------------------------------------------|------|------|----------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage                   | $I_D = 1 \text{ mA}$ , $V_{GS} = 0$                                           | 620  |      |          | V                              |
| $I_{DSS}$     | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = 620 \text{ V}$<br>$V_{DS} = 620 \text{ V}$ , $T_C = 125 \text{ °C}$ |      |      | 1<br>50  | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$     | Gate-body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20 \text{ V}$ ; $V_{DS} = 0$                                    |      |      | $\pm 10$ | $\mu\text{A}$                  |
| $V_{GS(th)}$  | Gate threshold voltage                           | $V_{DS} = V_{GS}$ , $I_D = 50 \text{ }\mu\text{A}$                            | 3    | 3.6  | 4.5      | V                              |
| $R_{DS(on)}$  | Static drain-source on resistance                | $V_{GS} = 10 \text{ V}$ , $I_D = 2.1 \text{ A}$                               |      | 1.28 | 1.6      | $\Omega$                       |

**Table 5. Dynamic**

| Symbol                              | Parameter                                                               | Test conditions                                                                                  | Min. | Typ.             | Max. | Unit           |
|-------------------------------------|-------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------|------|------------------|------|----------------|
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input capacitance<br>Output capacitance<br>Reverse transfer capacitance | $V_{DS} = 50 \text{ V}$ , $f = 1 \text{ MHz}$ ,<br>$V_{GS} = 0$                                  | -    | 690<br>52<br>8.5 | -    | pF<br>pF<br>pF |
| $C_{OSS \text{ eq}}^{(1)}$          | Equivalent output capacitance                                           | $V_{GS} = 0$ , $V_{DS} = 0 \text{ to } 496 \text{ V}$                                            |      | 16.6             |      | pF             |
| $R_g$                               | Gate input resistance                                                   | $f = 1 \text{ MHz}$ open drain                                                                   | -    | 4                | -    | $\Omega$       |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$       | Total gate charge<br>Gate-source charge<br>Gate-drain charge            | $V_{DD} = 496 \text{ V}$ , $I_D = 4.2 \text{ A}$ ,<br>$V_{GS} = 10 \text{ V}$<br>(see Figure 18) | -    | 27<br>4<br>16    | -    | nC<br>nC<br>nC |

1.  $C_{OSS \text{ eq}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{OSS}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 6. Switching times**

| Symbol                                        | Parameter                                                           | Test conditions                                                                                                               | Min. | Typ.                | Max | Unit                 |
|-----------------------------------------------|---------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------|------|---------------------|-----|----------------------|
| $t_{d(on)}$<br>$t_r$<br>$t_{d(off)}$<br>$t_f$ | Turn-on delay time<br>Rise time<br>Turn-off-delay time<br>Fall time | $V_{DD} = 310 \text{ V}$ , $I_D = 4.2 \text{ A}$ ,<br>$R_G = 4.7 \text{ }\Omega$ , $V_{GS} = 10 \text{ V}$<br>(see Figure 17) | -    | 12<br>8<br>40<br>21 | -   | ns<br>ns<br>ns<br>ns |

Table 7. Source drain diode

| Symbol          | Parameter                     | Test conditions                                                | Min. | Typ. | Max  | Unit |
|-----------------|-------------------------------|----------------------------------------------------------------|------|------|------|------|
| $I_{SD}$        | Source-drain current          |                                                                | -    |      | 4.2  | A    |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |                                                                | -    |      | 16.8 | A    |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 4.2 \text{ A}$ , $V_{GS} = 0$                        | -    |      | 1.5  | V    |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 4.2 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ | -    | 290  |      | ns   |
| $Q_{rr}$        | Reverse recovery charge       | $V_{DD} = 60 \text{ V}$                                        | -    | 1900 |      | nC   |
| $I_{RRM}$       | Reverse recovery current      | (see Figure 19)                                                | -    | 13   |      | A    |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 4.2 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ | -    | 320  |      | ns   |
| $Q_{rr}$        | Reverse recovery charge       | $V_{DD} = 60 \text{ V}$ , $T_J = 150 \text{ }^\circ\text{C}$   | -    | 2200 |      | nC   |
| $I_{RRM}$       | Reverse recovery current      | (see Figure 19)                                                | -    | 14   |      | A    |

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

Table 8. Gate-source Zener diode

| Symbol        | Parameter                     | Test conditions                         | Min. | Typ. | Max. | Unit |
|---------------|-------------------------------|-----------------------------------------|------|------|------|------|
| $V_{(BR)GSO}$ | Gate-source breakdown voltage | $I_{GS} = \pm 1 \text{ mA}$ , $I_D = 0$ | 30   | -    | -    | V    |

The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for I<sup>2</sup>PAKFP

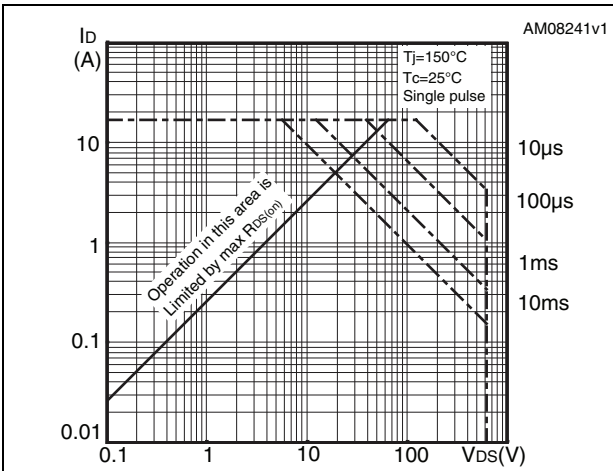


Figure 3. Thermal impedance for I<sup>2</sup>PAKFP

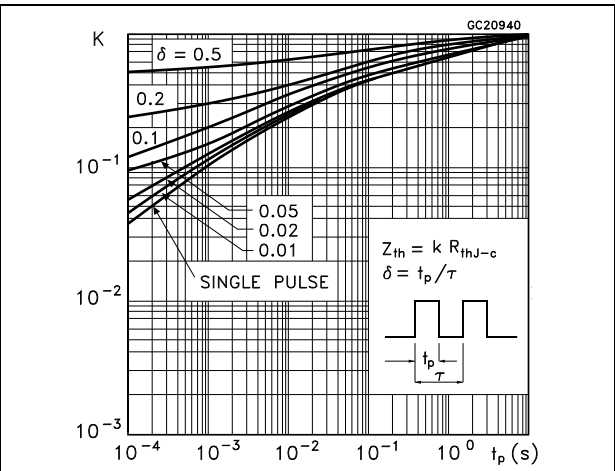


Figure 4. Safe operating area for TO-220

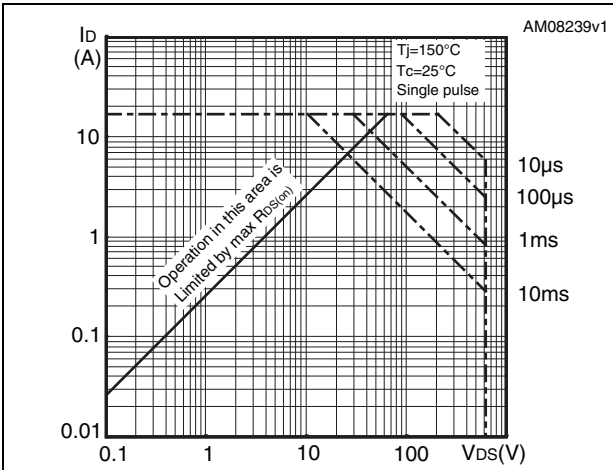


Figure 5. Thermal impedance TO-220

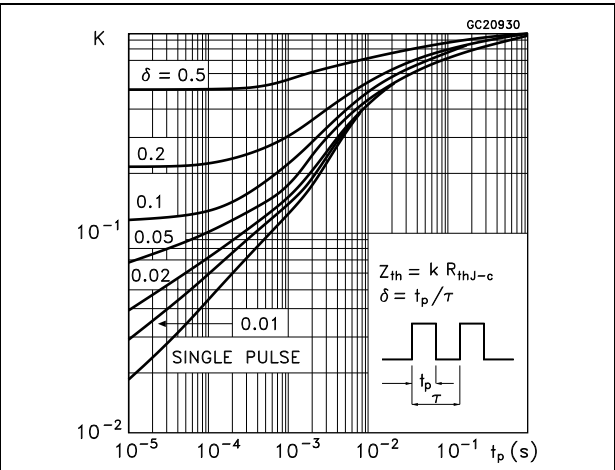


Figure 6. Output characteristics

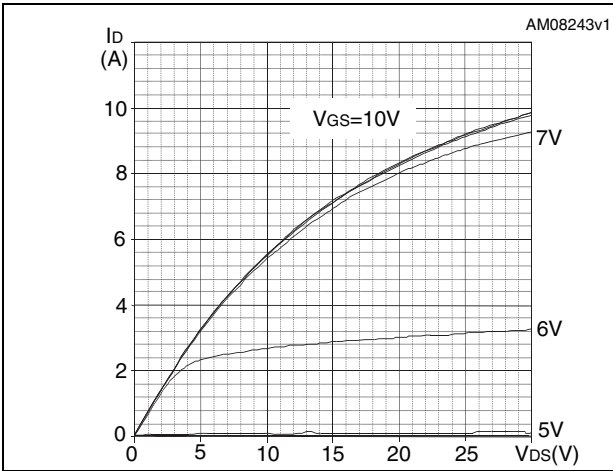


Figure 7. Transfer characteristics

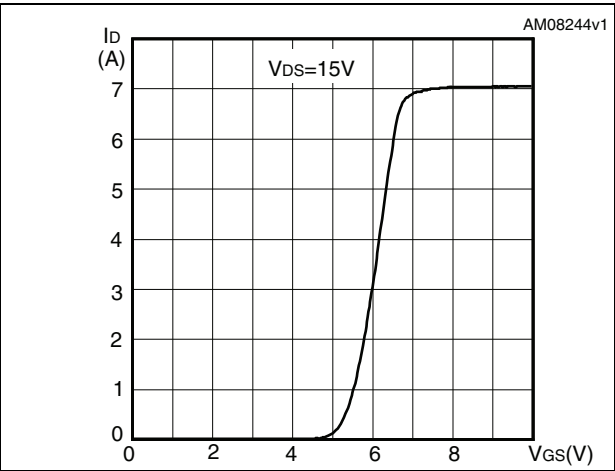


Figure 8. Gate charge vs gate-source voltage

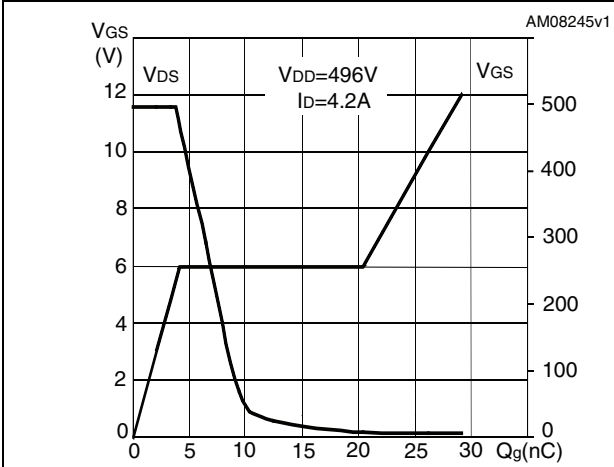


Figure 9. Static drain-source on-resistance

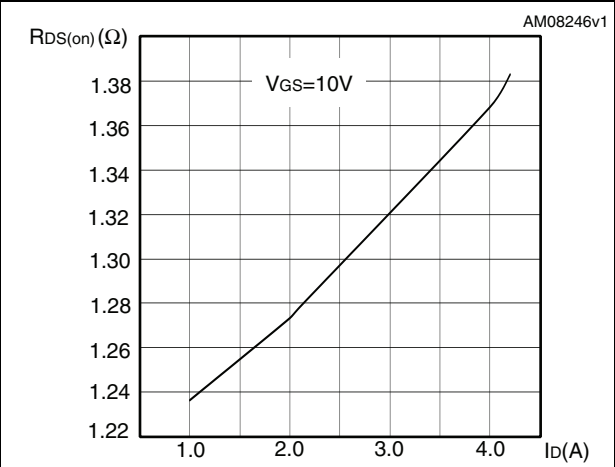


Figure 10. Capacitance variations

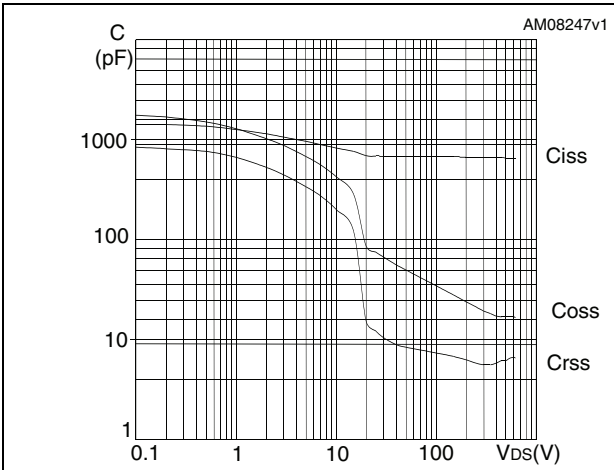


Figure 11. Output capacitance stored energy

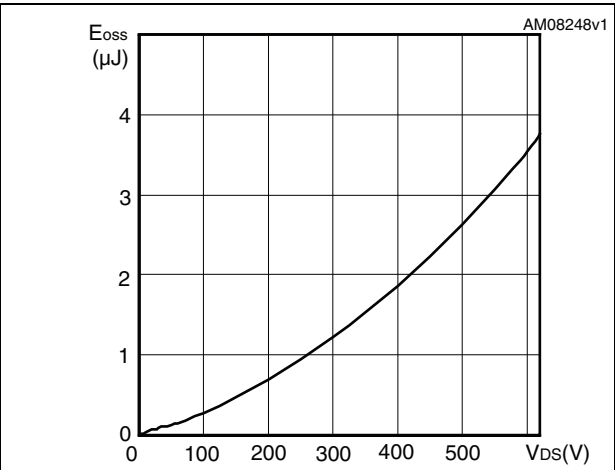


Figure 12. Normalized gate threshold voltage vs temperature

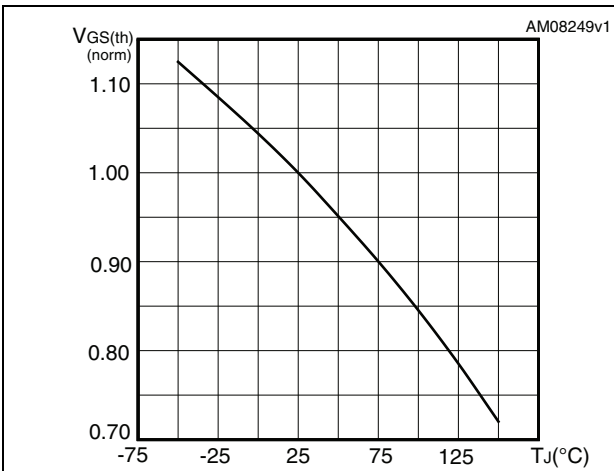


Figure 13. Normalized on-resistance vs temperature

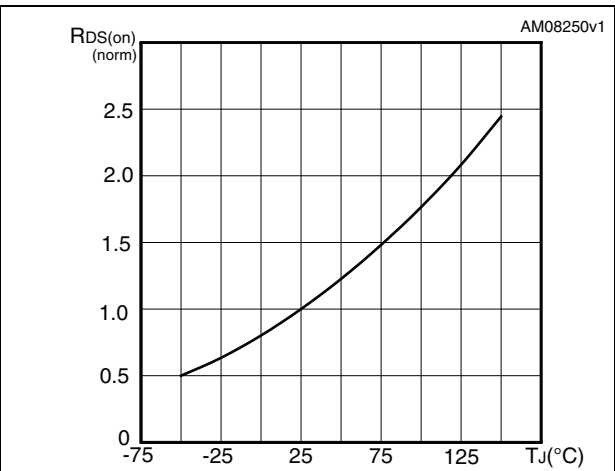


Figure 14. Source-drain diode forward characteristics

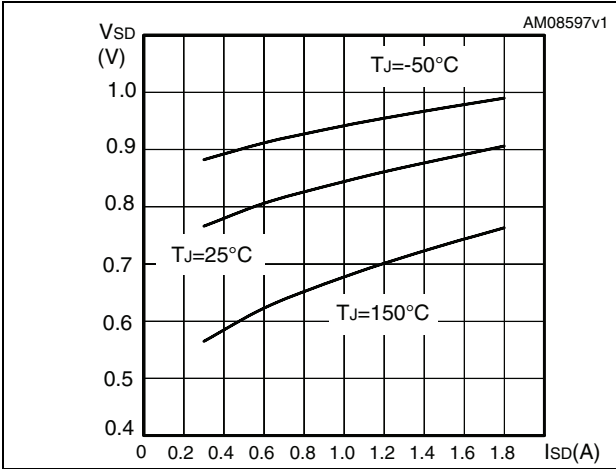


Figure 15. Normalized  $B_{VDSS}$  vs temperature

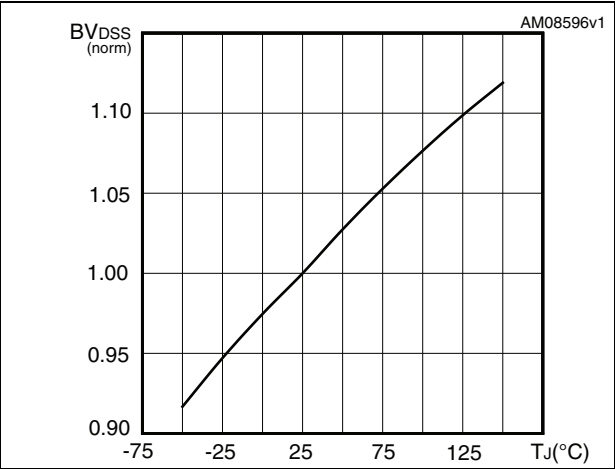
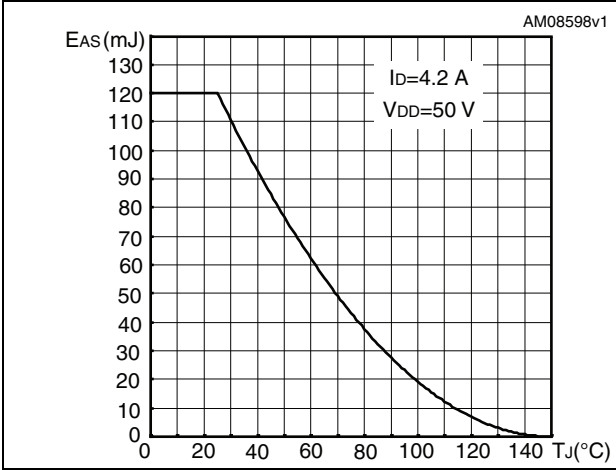


Figure 16. Maximum avalanche energy vs starting  $T_J$



### 3 Test circuits

Figure 17. Switching times test circuit for resistive load



Figure 18. Gate charge test circuit

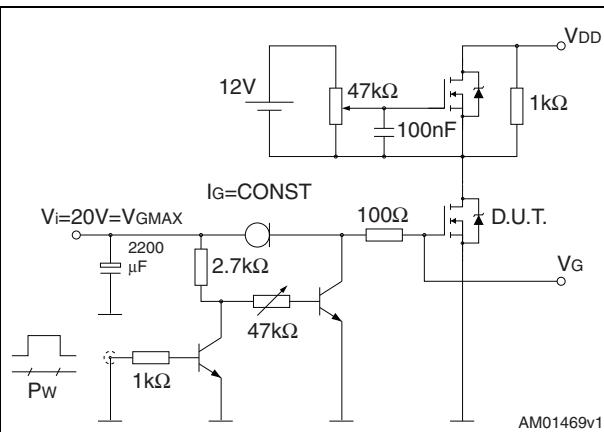


Figure 19. Test circuit for inductive load switching and diode recovery times

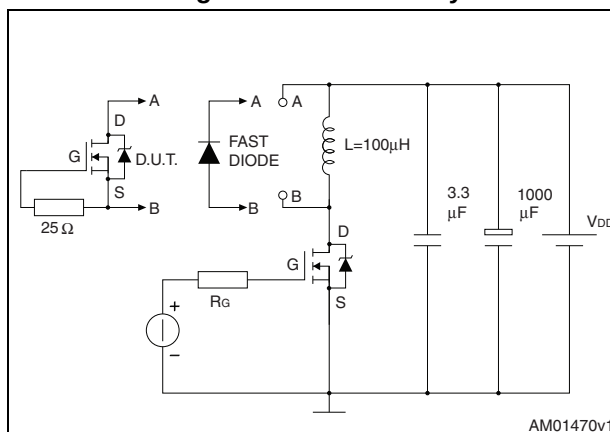


Figure 20. Unclamped inductive load test circuit

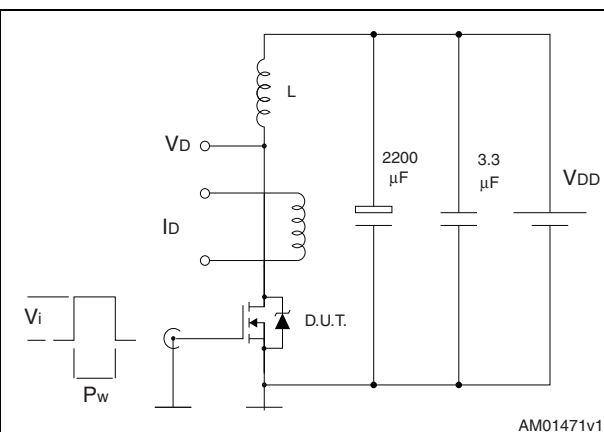


Figure 21. Unclamped inductive waveform

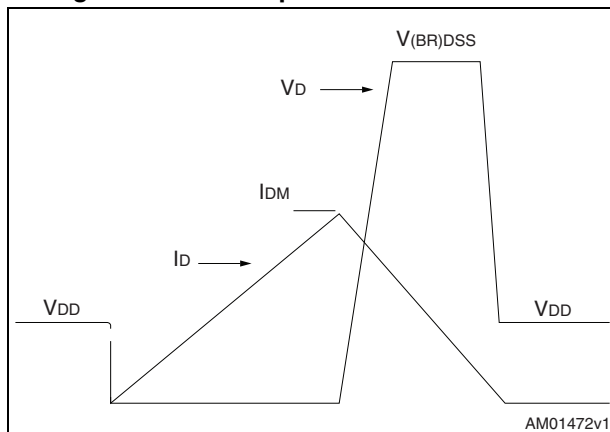


Figure 22. Switching time waveform



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

**Table 9. I<sup>2</sup>PAKFP (TO-281) mechanical data**

| Dim. | mm    |      |       |
|------|-------|------|-------|
|      | Min.  | Typ. | Max.  |
| A    | 4.40  | -    | 4.60  |
| B    | 2.50  |      | 2.70  |
| D    | 2.50  |      | 2.75  |
| D1   | 0.65  |      | 0.85  |
| E    | 0.45  |      | 0.70  |
| F    | 0.75  |      | 1.00  |
| F1   |       |      | 1.20  |
| G    | 4.95  |      | 5.20  |
| H    | 10.00 |      | 10.40 |
| L1   | 21.00 |      | 23.00 |
| L2   | 13.20 |      | 14.10 |
| L3   | 10.55 |      | 10.85 |
| L4   | 2.70  |      | 3.20  |
| L5   | 0.85  |      | 1.25  |
| L6   | 7.30  |      | 7.50  |

**Figure 23. I<sup>2</sup>PAKFP (TO-281) drawing**

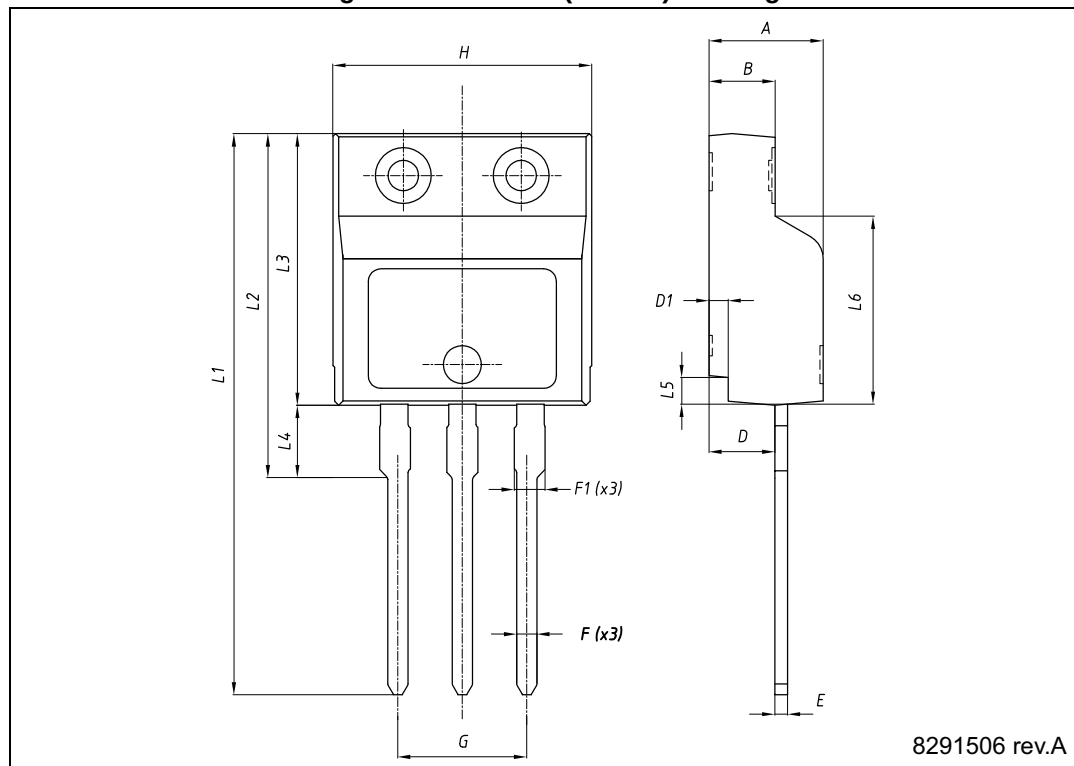
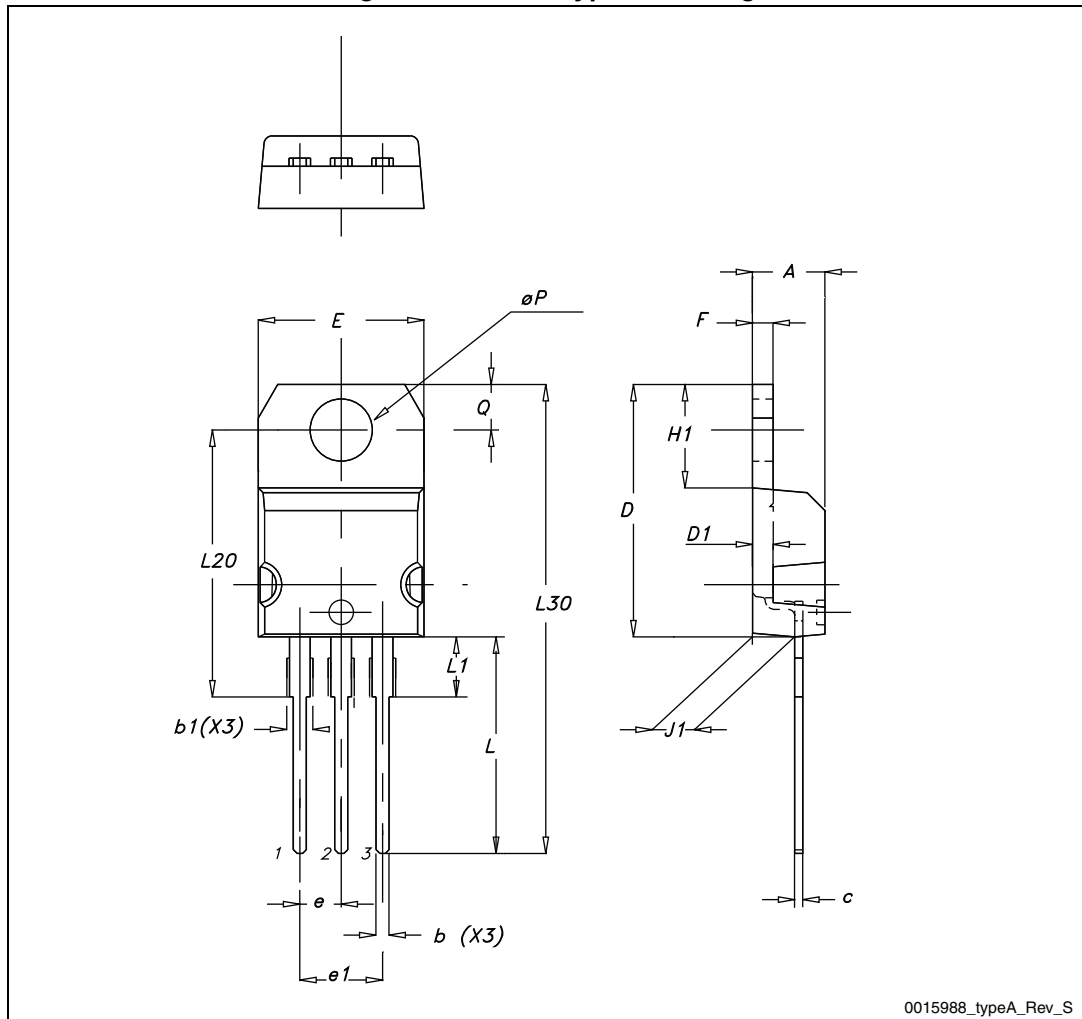


Table 10. TO-220 type A mechanical data

| Dim. | mm    |       |       |
|------|-------|-------|-------|
|      | Min.  | Typ.  | Max.  |
| A    | 4.40  |       | 4.60  |
| b    | 0.61  |       | 0.88  |
| b1   | 1.14  |       | 1.70  |
| c    | 0.48  |       | 0.70  |
| D    | 15.25 |       | 15.75 |
| D1   |       | 1.27  |       |
| E    | 10    |       | 10.40 |
| e    | 2.40  |       | 2.70  |
| e1   | 4.95  |       | 5.15  |
| F    | 1.23  |       | 1.32  |
| H1   | 6.20  |       | 6.60  |
| J1   | 2.40  |       | 2.72  |
| L    | 13    |       | 14    |
| L1   | 3.50  |       | 3.93  |
| L20  |       | 16.40 |       |
| L30  |       | 28.90 |       |
| ØP   | 3.75  |       | 3.85  |
| Q    | 2.65  |       | 2.95  |

Figure 24. TO-220 type A drawing



## 5 Revision history

**Table 11. Document revision history**

| Date        | Revision | Changes        |
|-------------|----------|----------------|
| 25-Mar-2013 | 1        | First release. |

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